

DMS3019SSD

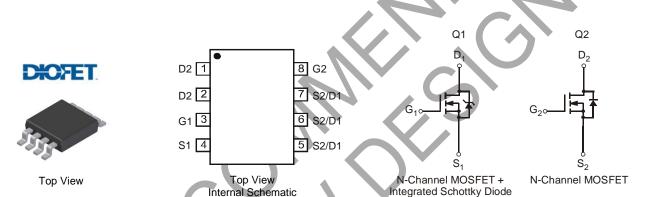
ASYMMETRIC DUAL N-CHANNEL ENHANCEMENT MODE MOSFET

Features

- DIOFET Utilizes a Unique Patented Process to Monolithically Integrate a MOSFET and a Schottky in a Single Die To Deliver:
 - Low R_{DS(on)}—Minimizes Conduction Loss
 - Low V_{SD}—Reduces Losses Due to Body Diode Construction
 - Low Q_{rr}—Lower Q_{rr} of Integrated Schottky Reduces Body
 Diode Switching Losses
 - Low Gate Capacitance (Q_g/Q_{gs}) Ratio—Reduces Risk of Shoot-Through or Cross Conduction Currents at High Frequencies
 - Avalanche Rugged—I_{AR} and E_{AR} Rated
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram Below
- Weight: 0.072 grams (Approximate)



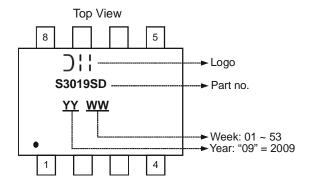
Ordering Information (Note 3)

Part Number	Case	Packaging
DMS3019SSD-13	SO-8	2500/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds
- 4. For packaging details, go to our website at http://www.diodes.com/.

Marking Information





Maximum Ratings – Q1 @TA = 25°C unless otherwise specified

Characteri	Symbol	Value	Unit		
Drain-Source Voltage	V _{DSS}	30	V		
Gate-Source Voltage	V _{GSS}	±12	V		
Continuous Drain Current (Note 4) V _{GS} = 10V	Steady State	T _A = 25°C T _A = 70°C	I _D	7.0 5.6	А
Continuous Drain Current (Note 5) V _{GS} = 10V	Steady State	$T_A = 25$ °C $T_A = 70$ °C	I _D	9.0 7.0	А
Continuous Drain Current (Note 5) V _{GS} = 4.5V	Steady State	T _A = 25°C T _A = 70°C	I _D	8.0 6.5	А
Pulsed Drain Current (Note 6)	I _{DM}	40	А		
Avalanche Current (Notes 6 & 7)			I _{AR}	13	А
Repetitive Avalanche Energy (Notes 6 & 7) L = 0.3mH			Ear	25.4	mJ

Maximum Ratings − Q2 @TA = 25°C unless otherwise specified

Characte	Symbol	Value	Unit		
Drain-Source Voltage			V _{DSS}	30	V
Gate-Source Voltage			V _{GSS}	±20	V
Continuous Drain Current (Note 4) V _{GS} = 10V	Steady State	$T_A = 25$ °C $T_A = 70$ °C	l _D	5.7 4.6	А
Continuous Drain Current (Note 5) V _{GS} = 10V	Steady State	$T_A = 25$ °C $T_A = 70$ °C	ID	7.0 5.6	А
Continuous Drain Current (Note 5) V _{GS} = 4.5V	Steady State	$T_A = 25$ °C $T_A = 70$ °C	I _D	6.0 4.7	Α
Pulsed Drain Current (Note 6)			I _D	40	А
Avalanche Current (Notes 6 & 7)			I _{AR}	16	Α
Repetitive Avalanche Energy (Notes 6 & 7) L =	0.1mH		E _{AR}	12.8	mJ

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 4)	P _D	1.19	W
Thermal Resistance, Junction to Ambient @T _A = 25°C (Note 4)	R _{0JA}	107	°C/W
Power Dissipation (Note 5)	P _D	1.79	W
Thermal Resistance, Junction to Ambient @T _A = 25°C (Note 5)	R _{0JA}	70	°C/W
Operating and Storage Temperature Range	T_{J}, T_{STG}	-55 to +150	°C

Notes:

- 4. Device mounted on FR-4 substrate PCB, with minimum recommended pad layout. The value in any given application depends on the user's specific
- board design. Device contains two active die running at equal power.

 5. Device mounted on 1 inch × 1 inch FR4 PCB with high coverage of single sided 1oz copper, in still air conditions. Device contains two active die running at equal power.
- 6. Repetitive rating, pulse width limited by junction temperature.
- 7. I_{AR} and E_{AR} rating are based on low frequency and duty cycles to keep $T_J = 25^{\circ}C$



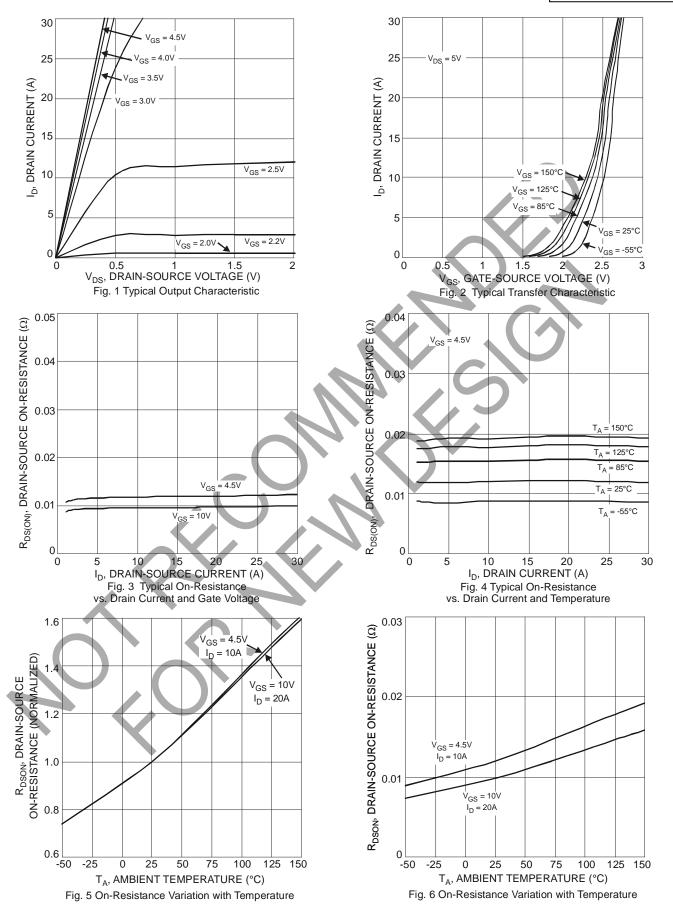
Electrical Characteristics – Q1 @ TA = 25°C unless otherwise stated

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV _{DSS}	30	_	_	V	$V_{GS} = 0V$, $I_D = 1mA$	
Zero Gate Voltage Drain Current	I _{DSS}	_	_	0.1	mA	$V_{DS} = 30V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 12V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	V _{GS(th)}	1.0	_	2.4	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
Static Drain-Source On-Resistance			10	15	mΩ	$V_{GS} = 10V, I_{D} = 9A$	
Static Dialif-Source Off-Resistance	R _{DS} (ON)	_	12	18	11122	$V_{GS} = 4.5V, I_{D} = 7A$	
Forward Transfer Admittance	Y _{fs}	_	5	_	S	$V_{DS} = 5V, I_{D} = 9A$	
Diode Forward Voltage	V _{SD}	_	0.4	1	V	$V_{GS} = 0V, I_{S} = 1A$	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	C _{iss}		1932	_		45)/ //	
Output Capacitance	Coss	_	154		pF	$V_{DS} = 15V, V_{GS} = 0V,$ f = 1.0MHz	
Reverse Transfer Capacitance	Crss	_	121				
Gate Resistance	Rg	_	2.7	7	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge (V _{GS} = 4.5V)	Q_{g}	_	18.1	_		$V_{DS} = 15V$, $V_{GS} = 4.5V$, $I_{D} = 9A$	
Total Gate Charge (V _{GS} = 10V)	Qg	_	42.0		nC		
Gate-Source Charge	Q _{gs}	_	4.5		iiC	$V_{DS} = 15V, V_{GS} = 10V, I_{D} = 9A$	
Gate-Drain Charge	Q_{gd}	_	4.0	Ť		×)	
Turn-On Delay Time	t _{D(on)}	-//	6.16				
Turn-On Rise Time	t _r	- 1	7.22		70	$V_{GS} = 10V, V_{DS} = 15V,$	
Turn-Off Delay Time	t _{D(off)}		36.76	(ns	$R_G = 3\Omega$, $R_L = 1.7\Omega$	
Turn-Off Fall Time	t _f		5.38	/-			

Notes:

8. Short duration pulse test used to minimize self-heating effect.9. Guaranteed by design. Not subject to production testing.







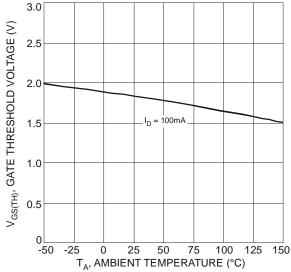
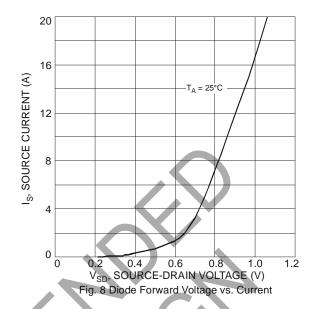
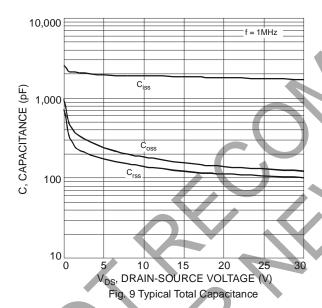
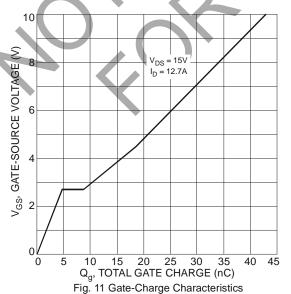
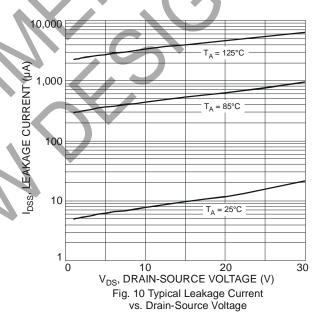


Fig. 7 Gate Threshold Variation vs. Ambient Temperature









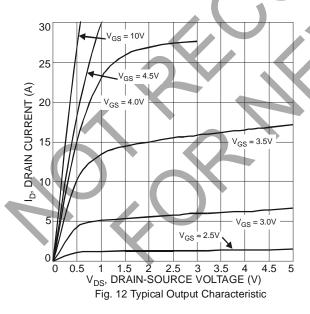


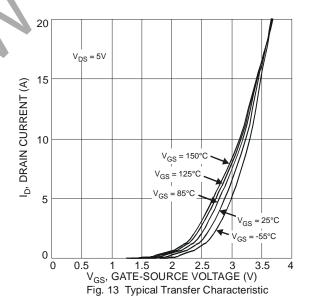
Electrical Characteristics – Q2 @ TA = 25°C unless otherwise stated

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV _{DSS}	30	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1.0	μΑ	$V_{DS} = 30V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	$V_{GS(th)}$	1.0	_	2.4	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Static Drain-Source On-Resistance	D		15	23	mΩ	$V_{GS} = 10V, I_D = 10A$
Static Drain-Source On-Nesistance	R _{DS} (ON)		25	33	11122	$V_{GS} = 4.5V$, $I_{D} = 7.5A$
Forward Transfer Admittance	Y _{fs}	_	2.5	_	S	$V_{DS} = 5V, I_{D} = 10A$
Diode Forward Voltage	V _{SD}	_	0.65	1.0	V	$V_{GS} = 0V$, $I_{S} = 1A$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C _{iss}	_	478.9	_		457777
Output Capacitance	Coss	_	96.7		pF	$V_{DS} = 15V, V_{GS} = 0V,$ f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}	_	61.4			I = 1.0IVINZ
Gate Resistance	Rg	0.4	1.1	1.6	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$
Total Gate Charge (V _{GS} = 4.5V)	Q_{g}	_	5.0			$V_{DS} = 15V$, $V_{GS} = 4.5V$, $I_{D} = 10A$
Total Gate Charge (V _{GS} = 10V)	Qg	_	10.5	1	nC	
Gate-Source Charge	Q_{gs}		1.8		l lic	$V_{DS} = 15V$, $V_{GS} = 10V$, $I_{D} = 10A$
Gate-Drain Charge	Q_{gd}	_	1.6	Ť	١ 🗼 ١	*
Turn-On Delay Time	t _{D(on)}	-//	2.9	_		
Turn-On Rise Time	t _r	- 1	7.9		no	$V_{GS} = 10V, V_{DS} = 15V,$
Turn-Off Delay Time	t _{D(off)}		14.6	,-(ns	$R_G = 3\Omega$, $R_L = 1.5\Omega$
Turn-Off Fall Time	t _f		3.1	//-		

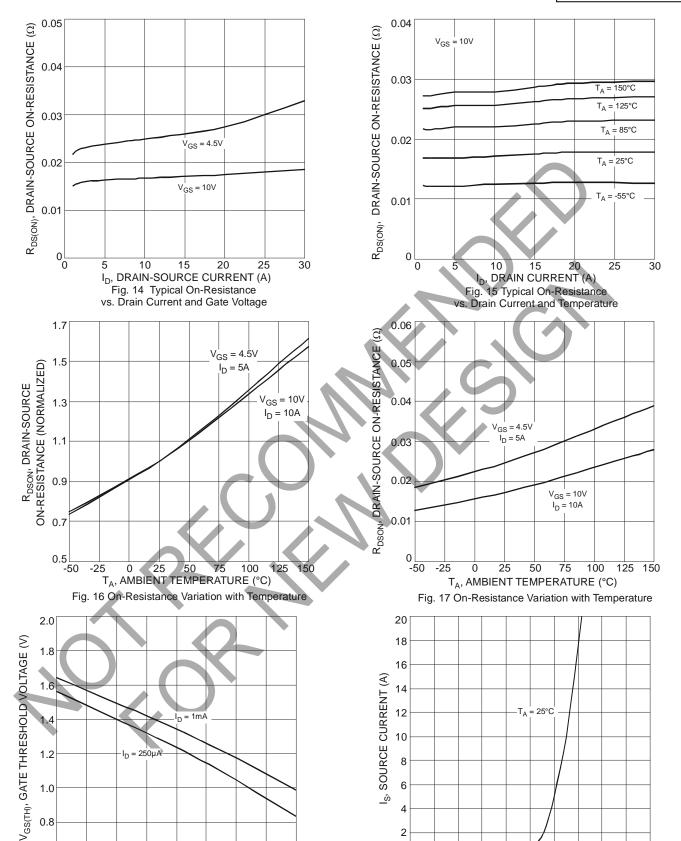
Notes:

- 8. Short duration pulse test used to minimize self-heating effect. 9. Guaranteed by design. Not subject to production testing.









2

0

0.2

0.6

0.8

V_{SD}, SOURCE-DRAIN VOLTAGE (V)

Fig. 19 Diode Forward Voltage vs. Current

T_A, AMBIENT TEMPERATURE (°C) Fig. 18 Gate Threshold Variation vs. Ambient Temperature

50

25

0.8

0.6

75

100 125 1.2

30



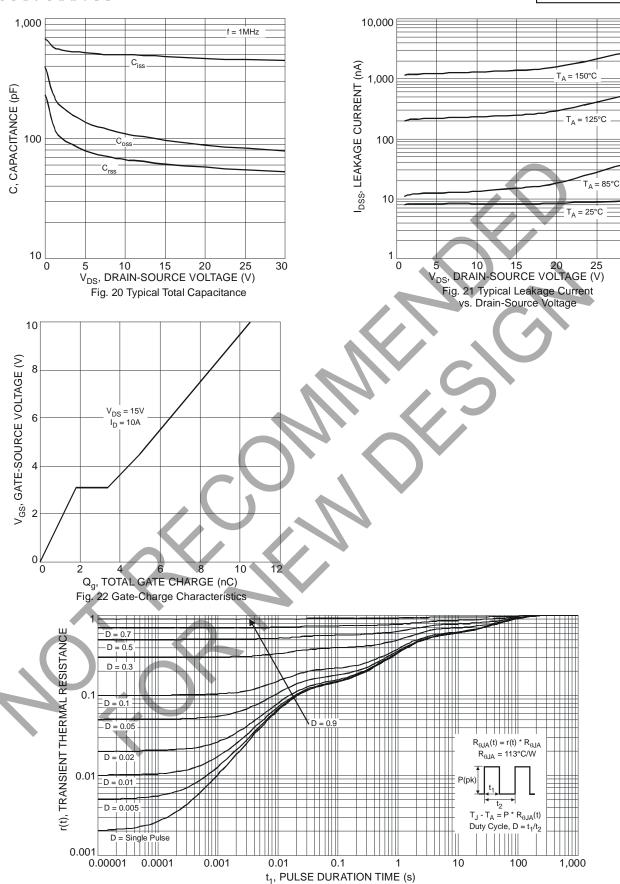
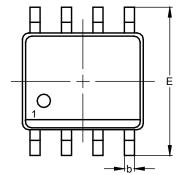


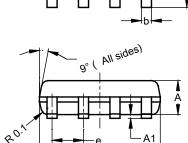
Fig. 23 Transient Thermal Response

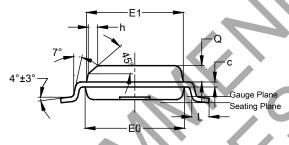


Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.





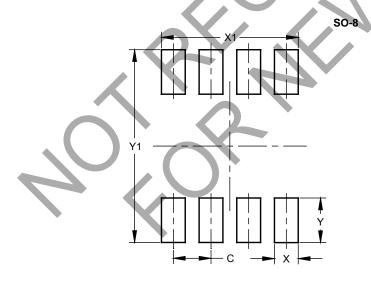


SO-8

SO-8						
Dim	Min	Max	Тур			
Α	1.40	1.50	1.45			
A 1	0.10	0.20	0.15			
b	0.30	0.50	0.40			
С	0.15	0.25	0.20			
D	4.85	4.95	4.90			
Е	5.90	6.10	6.00			
E1	3.80	3.90	3.85			
E0	3.85	3.95	3.90			
е			1.27			
h			0.35			
L	0.62	0.82	0.72			
ø	0.60	0.70	0.65			
All Dimensions in mm						

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.



Dimensions	Value (in mm)
C	1.27
X	0.802
X1	4.612
Y	1.505
Y1	6.50



IMPORTANT NOTICE

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel. Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

This document is written in English but may be translated into multiple languages for reference. Only the English version of this document is the final and determinative format released by Diodes Incorporated.

LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

- A. Life support devices or systems are devices or systems which:
 - 1. are intended to implant into the body, or
 - 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2018, Diodes Incorporated

www.diodes.com

DMS3019SSD Document number: DS35053 Rev. 3 - 3